

Search Notes

Application/Control No.

10/812,875

Examiner

Hai L. Nguyen

Applicant(s)/Patent under
Reexamination

CHOU ET AL.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
331	1A,1R, DIG.2	5/22/2005	HLN
331	16,18,25	—	
327	2,3,7,12	5/23/2005	
	39,40,42		
	43,47,49		
	141,142		
	162,163		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search	5/23/2005	HLN
EAST Text Search	5/23/2004	HLN